Sub-keV electro-cooled PGGe development at ASIoP



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OUTLINE:

- electro-cooled PCGe detector
- low energy physics
- challenge and development





Kuo Sheng Reactor Neutrino Laboratory



Kuo-Sheng Nuclear Power Station : Reactor Building

sub-keV neutrino physics



point contact Ge detector: from LN2 cooled to electro-cooled





70mm × 70mm ~ 1500g

electro-cooled PCGe

- vacuum pump on site
- low temperature, good resolution FWHM: 72.9 eV (-198°C) \rightarrow 72.3 eV (-200°C)
- noise-edge ~ 200 eV
- analysis threshold ~ 160 eV (?)
- shielding re-design optimized

for electro-cooled? \rightarrow heat problem



challenge at sub-keV

- Quenching Factors.
- Energy Definition & Calibration.
- Trigger Efficiencies near threshold.
- Physics vs. Noise Pulse-Shape Selection :
- algorithms & efficiencies.
- Bulk vs. Surface Events Selection :
 - algorithms & efficiencies.
- Background understanding

bulk/surface separation



energy defination at sub-keV



- high frequencies noise \rightarrow shift energy relative to pedestal-zero.
- low frequencies noise \rightarrow non-linear effect at < 100-200 eV.
- depend on energy definition : area of pulses, amplitude of pulses

what are noise?



- red : events with Ge-triggered + Cosmic-triggered + Nal-triggered
- black : only Ge-triggered (DM, ν)
- basic tools to separate signal/noise.
- tricks : to get the efficiencies correct.

what are noise?



in this sample, noise from shaping amp. ~ period of 30 μ s true signal do not always auto-correlated at 30 μ s.

<u>simulated signal+noise</u> <u>by software</u>



- data is taken with random-triggered (every ~ 10 sec.) \rightarrow pure noise
- in-situ noise
- simulated pulses, except timing information
- "measured" energy
- produce matched rise-time distributions of bulk



simulated signal+noise by hardware (pulser)



<u>simulated signal+noise</u>

by hardware:

- not in-situ noise
- simulated pulses include timing information
- "input" energy (before smear-out by energy resolution)
- produce matched rise-time distributions of bulk
- critical to answer

"probability to have a 180 eV events above 200 eV threshold"

both:

- all events selection, Bulk/Surf., non-linear correction and efficiencies at < 1 keV should be cross checked by both software and hardware signal+noise simulation
- enhanced statistic uncertainties.
- some efficiencies can only be calculated by noise simulation.

 more ideal for sub-keV signal/noise: neural network?
established filters?

others.



In KSNL							
High Voltage (V)	Shape Filter	Shaping time (µs)	Temp. (°C)	PED (σ) (eV)	FWHM (eV)		
3000	Triangular	6	-200	31.2	73.5		
3020	Triangular	6	-200	30.5	71.9		
3020	Triangular	4	-200	31.3	73.6		
3040	Triangular	6	-200	30.9	72.7		
3040	Triangular	6	-198	31.0	72.9		
3040	Triangular	6	-202	30.7	72.3		

ECGe 70*x*70 – *pPCGe*

In L114							
High Voltage (V)	Shape Filter	Shaping time (µs)	Temp. (°C)	PED (σ) (eV)	FWHM (eV)		
3000	Gaussian	6	-200	30.7	72.2		
3000	Triangular	6	-202	28.1	66.1		
3000	Triangular	6	-200	30.0	70.5		
3000	Triangular	4	-200	28.5	67.1		
3020	Triangular	6	-200	27.5	64.7		
3020	Triangular	6	-202	29.5	69.4		



